

Notice of References Cited	Application/Control No. 10/798,482		Applicant(s)/Patent Under Reexamination TAKAHASHI, AKIRA	
	Examiner William Kraig		Art Unit 2815	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,783,850	07-1998	Liau et al.	257/355
*	B	US-2003/0015763	01-2003	Yoneda, Kenji	257/411
*	C	US-5,637,900	06-1997	Ker et al.	257/355
*	D	US-6,103,603	08-2000	Han, Suk-Bin	438/532
*	E	US-6,020,240	02-2000	Wu, Shye-Lin	438/275
*	F	US-5,998,247	12-1999	Wu, Shye-Lin	438/200
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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